Search Notes



_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/837,862	DEKEL ET AL.	
	Examiner	Art Unit	
	Tòm Y. Lu	2621	

	SEARCHED				
Class	Subclass	Date	Examiner		
382	240, 276- 277, 282	6/29/2005	TYL		
375	240.19	6/29/2005	TYL		
348	211.3	6/29/2005	TYL		
709	203	6/29/2005	TYL		
715	744	6/29/2005	TYL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
see printo	ut attached	6/29/2005	TYL	

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
EAST search printout attached	6/29/2005	TYL
IEEE search	6/29/2005	TYL
PALM name search	6/29/2005	TYL
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